

Search Notes

Application/Control No.

09/716,227

Examiner

Kieu D. Vu

Applicant(s)/Patent under
Reexamination

KWON ET AL.

Art Unit

2173

SEARCHED

Class	Subclass	Date	Examiner
715	843	8/24/2006	KV
715	841	8/24/2006	KV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
USPAT-USPGPUB (See Search History)		8/24/2006	KV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR) (See Search History Printout)	8/24/2006	KV
715/810 715/735 725/37 725/40 725/43	8/24/2006	KV
http://www.google.com	8/24/2006	KV
IEEE Xplore	8/24/2006	KV